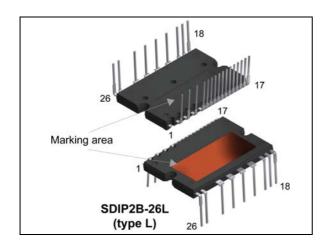


## STGIB30CH60TS-L

SLLIMM<sup>TM</sup> - 2<sup>nd</sup> series

IPM, 3-phase inverter, 30 A, 600 V short-circuit rugged IGBTs

Datasheet - preliminary data



#### **Features**

- IPM 30 A, 600 V 3-phase IGBT inverter bridge including 2 control ICs for gate driving and freewheeling diodes
- 3.3 V, 5 V TTL/CMOS inputs with hysteresis
- Internal bootstrap diode
- Under-voltage lockout of gate drivers
- Smart shutdown function
- Short-circuit protection
- Shutdown input/fault output
- Separate open emitter outputs
- Temperature sensor integrated
- Comparator for fault protection
- Short circuit rugged TGFS IGBTs
- Very fast, soft recovery diodes
- 85 kΩ NTC UL 1434 CA 4 recognized
- Fully isolated package
- Isolation rating of 1500 Vrms/min
- SLLIMM UL 1557 recognition on going Table 1. Device summary

Order code	Marking	Package	Packaging
STGIB30CH60TS-L	GIB30CH60TS-L	SDIP2B-26L	Tube

### **Applications**

- 3-phase inverters for motor drives
- Home appliances such as washing machines, refrigerators, air conditioners and sewing machine

#### **Description**

This second series of SLLIMM (small low-loss intelligent molded module) provides a compact, high performance AC motor drive in a simple, rugged design. It combines new ST proprietary control ICs (one LS and one HS driver) with the improved short-circuit rugged Trench Gate Field-Stop IGBT, making it ideal for 3-phase inverters systems such as home appliances and air conditioners. SLLIMM™ is a trademark of STMicroelectronics.

Contents STGIB30CH60TS-L

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Obsol	Revision history

# 1 Internal schematic and pin description

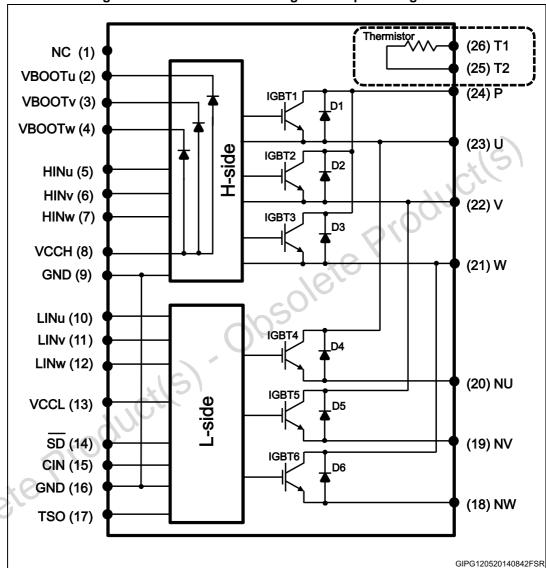


Figure 1. Internal schematic diagram and pin configuration

Table 2. Pin description

Pin	Symbol	Description
1	NC	-
2	VBOOTu	Bootstrap voltage for U phase
3	VBOOTv	Bootstrap voltage for V phase
4	VBOOTw	Bootstrap voltage for W phase
5	HINu	High-side logic input for U phase
6	HINv	High-side logic input for V phase
7	HINw	High-side logic input for W phase
8	VCCH	High-side low voltage power supply
9	GND	Ground
10	LINu	Low-side logic input for U phase
11	LINv	Low-side logic input for V phase
12	LINw	Low-side logic input for W phase
13	VCCL	Low-side low voltage power supply
14	SD	Shutdown logic input (active low) / open-drain (comparator output)
15	CIN	Comparator input
16	GND	Ground
17	TSO	Temperature sensor output
18	NW	Negative DC input for W phase
19	NV	Negative DC input for V phase
20	NU	Negative DC input for U phase
21	W	W phase output
22	V	V phase output
23	U	U phase output
24	Р	Positive DC input
25	T2	NTC thermistor terminal 2
26	T1	NTC thermistor terminal 1



# 2 Absolute maximum ratings

 $(T_i = 25$ °C unless otherwise noted).

Table 3. Inverter parts

Symbol	Parameter	Value	Unit
V <sub>CC</sub>	Supply voltage between P-N, -U,-V	450	V
V <sub>CC(surge)</sub>	Supply voltage surge between P-N, -U,-V	500	V
V <sub>CES</sub>	Collector-emitter voltage each IGBT	600	V
I <sub>C</sub>	Continuous collector current each IGBT	30	Α
I <sub>CP</sub>	Peak collector current each IGBT (less than 1ms)	60	А
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> =25°C each IGBT	71/0	W
t <sub>scw</sub>	Short circuit withstand time, $V_{CE} = 300V$ , $T_{J} = 125$ °C, $V_{CC} = V_{boot} = 15$ V, $V_{IN}^{(1)} = 0$ to 5 V	5	μs

<sup>1.</sup> Applied between HINx, LINx and GND for x = U, V, W

**Table 4. Control parts** 

	Symbol	Parameter	Min	Max	Unit
	V <sub>CC</sub>	Supply voltage between V <sub>CCH</sub> -GND, V <sub>CCL</sub> -GND	-0.3	20	V
	V <sub>BOOT</sub>	Bootstrap voltage	-0.3	620	V
	V <sub>OUT</sub>	Output voltage between U, V, W and GND	V <sub>BOOT</sub> - 20	V <sub>BOOT</sub> + 0.3	V
	V <sub>CIN</sub> Comparator input voltage		-0.3	15	V
V <sub>IN</sub> Logic input voltage ap		Logic input voltage applied between HINx, LINx and GND	-0.3	15	V
10	V <sub>SD</sub> /OD	Open drain voltage	-0.3	15	V
	I <sub>OD</sub>	Open drain sink current	-	10	mA
absol	V <sub>TSO</sub>	Temperature sensor output voltage	-0.3	7	V
OF					

Table 5. Total system

Symbol	Parameter	Value	Unit
V <sub>ISO</sub>	Isolation withstand voltage applied between each pin and heat sink plate (AC voltage, t = 60sec.)	1500	Vrms
$T_J$	Power chips operating junction temperature	-40 to 150	°C
T <sub>C</sub>	Module case operation temperature	-40 to 125	°C



Table 6. Thermal data

Symbol	Parameter	Value	Unit
D	Thermal resistance junction-case single IGBT	-	00/14/
R <sub>th(j-c)</sub>	Thermal resistance junction-case single diode	2.8	°C/W

Obsolete Product(s). Obsolete Product(s)

#### 3 **Electrical characteristics**

 $(T_i = 25$ °C unless otherwise noted).

Table 7. Inverter parts

Symbol	Parameter	Test condition	Min	Тур	Max	Uni
I <sub>CES</sub>	Collector-cut off current	V <sub>CE</sub> = 550 V, V <sub>CC</sub> = V <sub>boot</sub> = 15 V			-	μΑ
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	$V_{CC} = V_{Boot} = 15 \text{ V}, V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V},$ $I_{C} = 30 \text{ A},$		1.6	-	٧
V <sub>F</sub>	Diode forward voltage	$V_{IN}^{(1)} = 0, I_C = 30 A$		1.7	(1.5	V
Inductive	e load switching time a	and energy <sup>(2)</sup>	7	110		
t <sub>on</sub>	Turn-on time		$O_{C}$	-		
t <sub>con</sub>	Cross-over time on	$V_{DD} = 300 \text{ V}, V_{CC} = V_{boot} = 15 \text{ V},$ $V_{WV}^{(1)} = 0 \text{ to } 5 \text{ V} \text{ Io} = 30 \text{ A}$		-		
t <sub>off</sub>	Turn-off time			-		ns
t <sub>coff</sub>	Cross-over time off			-		
t <sub>rr</sub>	Reverse recovery time	$V_{IN}^{(1)} = 0 \text{ to } 5 \text{ V}, I_C = 30 \text{ A}$		-		
E <sub>ON</sub>	Turn-on switching loss			300		
E <sub>OFF</sub>	Turn-off switching loss			120		μJ
1. Applied	between HINx, LINx and	GND for x = U, V, W	1			1
2. t <sub>on</sub> and of IGBT	t <sub>off</sub> include the propagation Γ itself under the internally	delay time of the internal drive. $t_{C(ON)}$ and $t_{C}$ given gate driving condition.	<sub>(OFF)</sub> are	the sw	itching ti	me
2. t <sub>on</sub> and of IGBT						
3						

Electrical characteristics STGIB30CH60TS-L

Vcc BOOT Switching Low Side Lo

Figure 2. Switching time test circuit



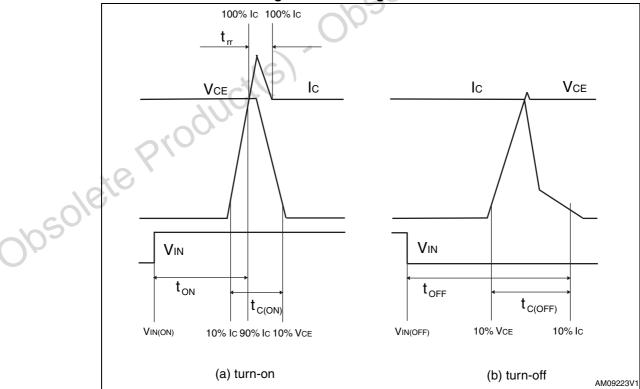


Table 8. Control / protection parts

		ontroi / protection parts	, 			
Symbol	Parameter	Test condition	Min	Тур	Max	Unit
V <sub>CC_hys</sub>	V <sub>CC</sub> UV hysteresis		1.1	1.4	1.7	V
V <sub>il</sub>	Low logic level voltage				0.8	V
V <sub>ih</sub>	High logic level voltage		2			V
I <sub>INh</sub>	IN logic "1" input bias current	IN <sub>x</sub> =15V		150		μA
I <sub>INI</sub>	IN logic "0" input bias current	IN <sub>x</sub> =0V			1	μA
High side					115	
V <sub>CCH_th(on)</sub>	V <sub>CCH</sub> UV turn-on threshold		11	11.5	12	V
V <sub>CCH_th(off)</sub>	V <sub>CCH</sub> UV turn-off threshold		9.6	10.1	10.6	V
V <sub>BS_hys</sub>	V <sub>BS</sub> UV hysteresis		0.7	1	1.3	V
V <sub>BS_th(on)</sub>	V <sub>BS</sub> UV turn-on threshold	40,	10.1	11	11.9	V
V <sub>BS_th(off)</sub>	V <sub>BS</sub> UV turn-off threshold	16/	9.1	10	10.9	V
I <sub>QBSU</sub>	Under voltage V <sub>BS</sub> quiescent current	$V_{BS} = 9 \text{ V, HINx}^{(1)} = 5 \text{V;}$		45	-	μA
I <sub>QBS</sub>	V <sub>BS</sub> quiescent current	V <sub>CC</sub> = 15 V, HINx <sup>(1)</sup> = 5V		80	-	μA
I <sub>qccu</sub>	Under voltage quiescent supply current	$V_{CC} = 9 \text{ V, HINx}^{(1)} = 0$		270	-	μΑ
I <sub>qcc</sub>	Quiescent current	V <sub>CC</sub> = 15 V, HINx <sup>(1)</sup> = 0		520	-	μΑ
R <sub>DS(on)</sub>	BS driver ON resistance			140		Ω
Low side						
V <sub>CCL_th(on)</sub>	V <sub>CCL</sub> UV turn-on threshold		11	11.5	12	V
V <sub>CCL_th(off)</sub>	V <sub>CCL</sub> UV turn-off threshold		9.6	10.1	10.6	V
I <sub>qccu</sub>	Under voltage quiescent supply current	$V_{CC} = 10 \text{ V}, \overline{\text{SD}} \text{ pulled to}$ 5V through $R_{SD} = 10 k\Omega$ , $CIN = LINx^{1} = 0$ ;		640	-	μA
I <sub>qcc</sub>	Quiescent current	$V_{CC} = 15 \text{ V}, \overline{SD} = 5\text{V},$ $CIN = LINx^{1)} = 0;$		740	-	μA
V <sub>SSD</sub>	Smart SD unlatch threshold			0.6		V
I <sub>SDh</sub>	SD logic "1" input bias current	<del>SD</del> =15V		150		μA
I <sub>SDI</sub>	SD logic "0" input bias current	SD =0V			1	μΑ

<sup>1.</sup> Applied between HINx, LINx and GND for x = U, V, W

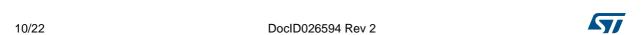


Electrical characteristics STGIB30CH60TS-L

Table 9. Sense comparator (V<sub>CC</sub> = 15 V, PGND=AGND=GND, unless otherwise is specified)

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
I <sub>ib</sub>	Input bias current	V <sub>CIN</sub> =1V	-	0	-	μΑ
V <sub>ref</sub>	Internal reference voltage		-	500	-	mV
V <sub>OD</sub>	Open drain low level output voltage	I <sub>od</sub> =-5mA	-		500	mV
t <sub>d_comp</sub>	Comparator delay	SD pulled to 5V through R <sub>SD</sub> =10kΩ; measured applying a voltage step 0V-3.3V to Pin CIN 50% CIN to 90% SD	-	30	19	ns
SR	Slew rate	SD pulled to 5V through R <sub>SD</sub> =10kΩ; C <sub>L</sub> =1nF through SD and ground; 90% SD to 10% SD	20	30		V/µs

Note: Comparator stay enabled even if V<sub>CC</sub> is in UVLO condition but higher than 4 V.



STGIB30CH60TS-L Fault management

### 4 Fault management

The device integrates an open-drain output connected to  $\overline{SD}$  Pin. As soon as a fault occurs the open-drain is activated and LVGx outputs are forced low. Two types of fault can be pointed out:

- Overcurrent (OC) sensed by the internal comparator (see more detail in Section 4.2: Smart shutdown function);
- Undervoltage on supply voltage (V<sub>CC</sub>);

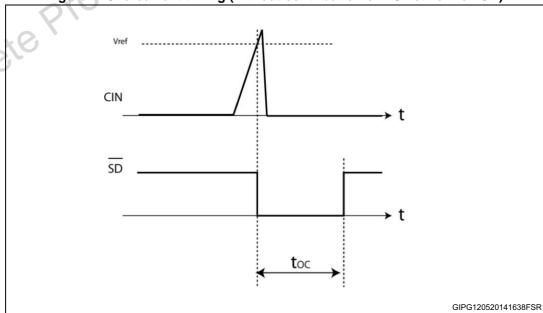
Each fault enables the SD open drain for a different time; refer to the following *Table 10: Fault timing*.

Table 10. Fault timing

Symbol	Parameter	Event time	SD open-drain enable time result
ОС	Over-current event	≤ 20 µs	20 μs
	Over-current event	≥ 20µs	OC time
		≤ 50 µs	50µs
UVLO	Under-voltage lock out event	≥ 50µs until the VCC_LS exceed the VCC_LS UV turn ON threshold	UVLO time

Actually the device remains in a fault condition ( $\overline{SD}$  at low logic level and LVGx outputs disabled) for a time also depending on RC network connected to  $\overline{SD}$  pin. The network generate a time contribute that add up to the internal value.

Figure 4. Overcurrent timing (without contribution of RC network on SD)



Fault management STGIB30CH60TS-L

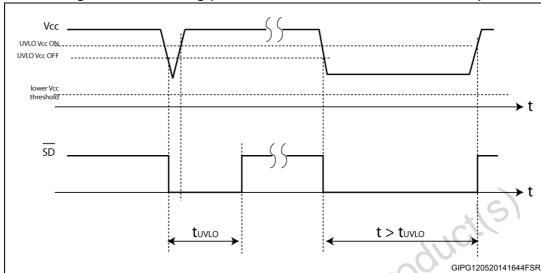


Figure 5. UVLO timing (without contribution of RC network on SD)

### 4.1 TSO output

The device integrates temperature sensor. A voltage proportional to die temperature is available on TSO pin. When this function is not used the Pin can be left floating.

#### 4.2 Smart shutdown function

The device integrates a comparator committed to the fault sensing function. The comparator input can be connected to an external shunt resistor in order to implement a simple overcurrent detection function.

The output signal of the comparator is fed to an integrated MOSFET with the open drain output available on SD input. When the comparator triggers, the device is set in shutdown state and its outputs are all set to low level.

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STGIB30CH60TS-L Fault management

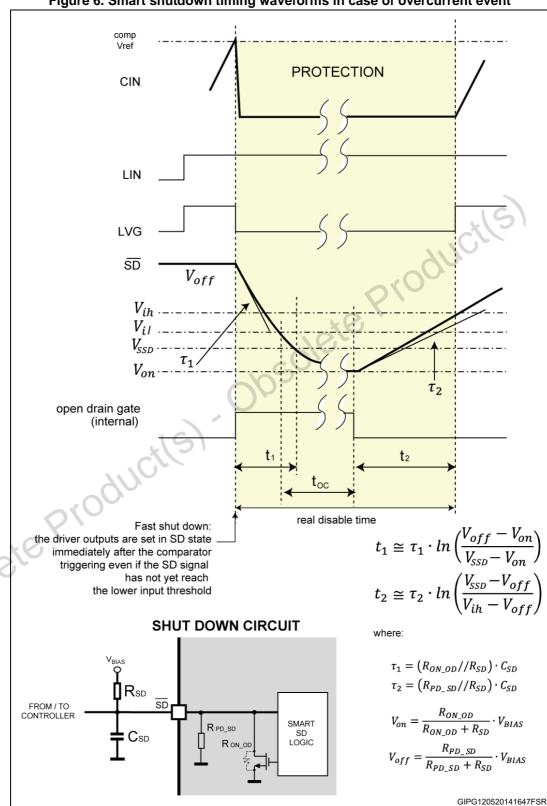


Figure 6. Smart shutdown timing waveforms in case of overcurrent event

Note:  $R_{ON\_OD}=V_{OD}/I_{OD}$  see Table 9;  $R_{PD\_SD}$  (typ) =125 k $\Omega$ 



Fault management STGIB30CH60TS-L

In common over-current protection architectures the comparator output is usually connected to the  $\overline{SD}$  input and an RC network is connected to this  $\overline{SD}$  line in order to provide a monostable circuit, which implements a protection time that follows the fault condition.

Differently from the common fault detection systems, the device Smart shutdown architecture allows to immediately turn-off the outputs gate driver in case of fault, by minimizing the propagation delay between the fault detection event and the actual outputs switch-off. In fact the time delay between the fault and the outputs turn off is no more dependent on the RC value of the external network connected to the pin.

In the smart shutdown circuitry, the fault signal has a preferential path which directly switches off the outputs after the comparator triggering.

At the same time the internal logic turns on the open drain output and holds it on until the SD voltage goes below the  $V_{SSD}$  threshold and  $t_{oc}$  time is elapsed.

The driver outputs restart following the input pins as soon as the voltage at the  $\overline{SD}$  pin reaches the higher threshold of the  $\overline{SD}$  logic input.

The Smart shutdown system provides the possibility to increase the time constant of the external RC network (that is the disable time after the fault event) up to very large values without increasing the delay time of the protection.



# 5 Typical application circuit

<del>-</del>|||-3 ₩ ₩ ₩ ~ | | 2 | 2 GIPG120520142239FSR

Figure 7. Typical application circuit

Recommendations STGIB30CH60TS-L

#### 6 Recommendations

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1. Input signals HIN, LIN are active-high logic. A 500 k $\Omega$  (typ.) pull-down resistor is built-in for each high side input. To prevent input signal oscillation, the wiring of each input should be as short as possible and the use of RC filters (R1, C1) on each input signal is suggested. The filters should be done with a time constant of about 100 ns and must be placed as close as possible to the IPM input pins.

- 2. The bypass capacitor Cvcc (aluminum or tantalum) is recommended to reduce the transient circuit demand on the power supply. In addition, a decoupling capacitor C2 (100 to 220 nF, ceramic with low ESR) is suggested, to reduce high frequency switching noise distributed on the power supply lines. It must be placed as close as possible to each Vcc pin and in parallel to the bypass capacitor.
- 3. The use of RC filter (RSF, CSF) for preventing protection circuit malfunction is recommended. The time constant (RSF x CSF) should be set to 1 µs and the filter must be placed as close as possible to the CIN pin.
- 4. The  $\overline{SD}$  is an input/output pin (open drain type if used as output). It should be pulled up to MCU power supply (3.3/5 V) by a resistor higher than 1.8 k $\Omega$  in order to keep load lower than 3 mA. The filter on  $\overline{SD}$  has to be sized to  $\underline{get}$  a desired re-starting time after a fault event and placed as close as possible to the  $\underline{SD}$  pin.
- 5. To increase the noise immunity of the NTC thermistor or/and TSO thermal sensor, it is recommended to parallel a decoupling capacitor (COT and CTSO), whose values must be between 10 and 100 nF and placed close to the MCU.
- 6. The decoupling capacitor C3 (100 to 220 nF, ceramic with low ESR), in parallel to each Cboot, is recommended in order to filter high frequency disturbances.
- 7. The decoupling capacitor C4 (100 to 220 nF, ceramic with low ESR) in parallel to the electrolytic capacitor Cvdc is recommended, in order to prevent surge destruction. Both capacitors C4 and Cvdc should be placed as close as possible to the IPM (C4 has priority over Cvdc).
- 8. By integrating an application-specific type HVIC inside the module, direct coupling to the MCU terminals without an opto-coupler is possible.
- Low inductance shunt resistors should be used for phase leg current sensing
- 10. In order to avoid malfunctions, the wiring between N pins, the shunt resistor and PWR\_GND should be as short as possible.
- 11. It is recommended to connect SGN\_GND to PWR\_GND at only one point (near the terminal of shunt resistor), in order to avoid any malfunction due to power ground fluctuation.
- 12. Bootstrap negative electrodes should be connected to U,V,W terminals directly and separated from the main output wires.

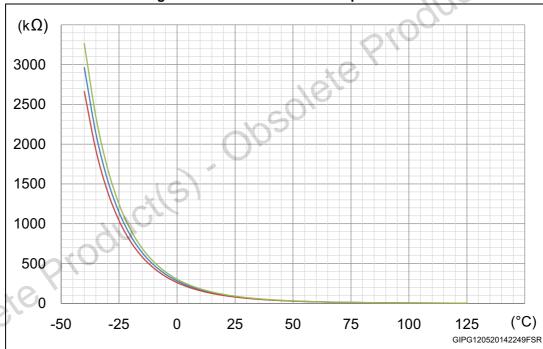
STGIB30CH60TS-L NTC thermistor

# 7 NTC thermistor

**Table 11. NTC thermistor** 

Symbol	Parameter	Test condition	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance	T = 25°C		85	-	kΩ
R <sub>125</sub>	Resistance	T = 100°C		2.6	-	kΩ
В	B-constant	T = 25°C to 100°C		4092	-	K
Т	Operating temperature range		-40		125	°C

Figure 8. NTC resistance vs. temperature



NTC thermistor STGIB30CH60TS-L

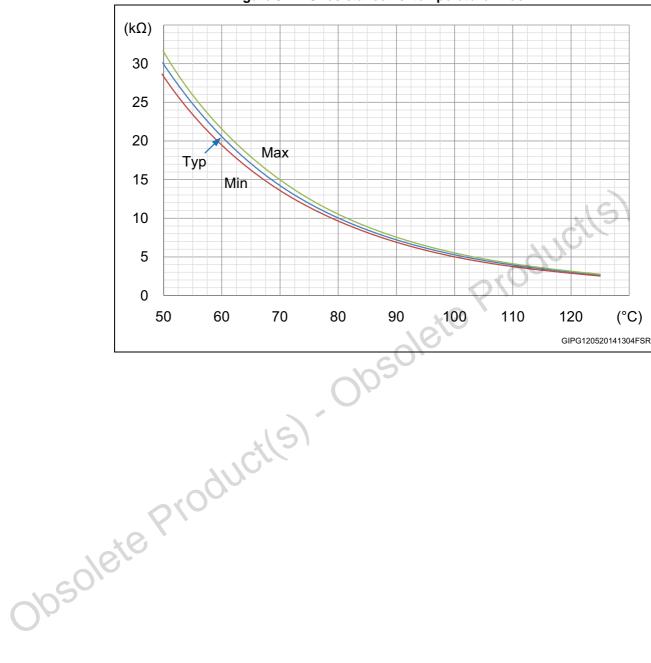


Figure 9. NTC resistance vs. temperature - zoom

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# 8 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



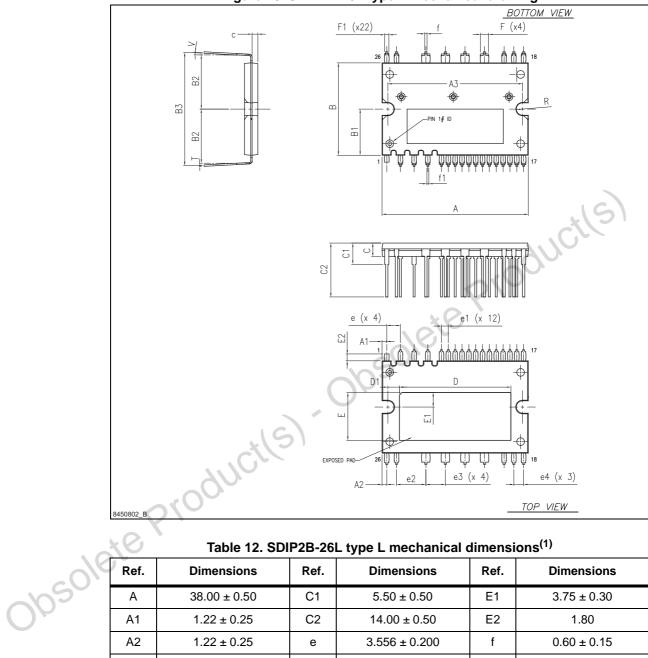


Figure 10. SDIP2B-26L type L mechanical drawing

Table 12. SDIP2B-26L type L mechanical dimensions<sup>(1)</sup>

Ref.	Dimensions	Ref.	Dimensions	Ref.	Dimensions
Α	38.00 ± 0.50	C1	$5.50 \pm 0.50$	E1	$3.75 \pm 0.30$
A1	1.22 ± 0.25	C2	14.00 ± 0.50	E2	1.80
A2	1.22 ± 0.25	е	3.556 ± 0.200	f	0.60 ± 0.15
А3	35.00 ± 0.30	e1	1.778 ± 0.200	f1	0.50 ± 0.15
С	1.50 ± 0.05	e2	7.62 ± 0.20	F	2.10 ± 0.15
В	24.00 ± 0.50	e3	5.08 ± 0.20	F1	1.10 ± 0.15
B1	12.00	e4	2.54 ± 0.20	R	1.60 ± 0.20
B2	14.40 ± 0.50	D	28.95 ± 0.50	Т	0.400 ± 0.025
В3	29.40 ± 0.50	D1	3.025 ± 0.300	V	0° / 5°
С	3.50 ± 0.20	Е	12.40 ± 0.50		

<sup>1.</sup> All dimensions are expressed in millimeters.

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STGIB30CH60TS-L Revision history

# 9 Revision history

Table 13. Document revision history

Date	Revision	Changes	
23-Jun-2014	1	Initial release.	
27-Aug-2014 2		Updated Table 1: Device summary.	



#### IMPORTANT NOTICE - PLEASE READ CAREFULLY

Obsolete Product(s)

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